

**Search Notes**

Application/Control No.

10/707,106

Examiner

Than Nguyen

Applicant(s)/Patent under  
Reexamination

CHANG ET AL.

Art Unit

2187

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Update prior art review from previous search	5/30/2006	NTV